

WEST Search History

DATE: Tuesday, April 19, 2005

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	<i>DB=PGPB,USPT,JPAB; PLUR=YES; OP=OR</i>		
<input type="checkbox"/>	L14	L13 and simulation	17
<input type="checkbox"/>	L13	l5 and L12	24
<input type="checkbox"/>	L12	linear same network	20777
<input type="checkbox"/>	L11	L10 and (communication same network)	1
<input type="checkbox"/>	L10	L9 and telecommunication	1
<input type="checkbox"/>	L9	L8 and network	18
<input type="checkbox"/>	L8	L5 and simulation and (netlist or net)	19
<input type="checkbox"/>	L7	L5 and simulation and (netlist or net) and (diagonal\$ or chain\$)	11
<input type="checkbox"/>	L6	L5 and simulation and (netlist or net) and (diagonal\$)	11
<input type="checkbox"/>	L5	parameter same (admittance or conductance) same matri\$	100
<input type="checkbox"/>	L4	L3 and parameter and chain\$4	4
<input type="checkbox"/>	L3	simulation and netlist and circuit and admittance	20
<input type="checkbox"/>	L2	krakovian and admittance	1
<input type="checkbox"/>	L1	krakovian and matrix and admittance	1

END OF SEARCH HISTORY



US006785873B1

(12) **United States Patent**
Tseng(10) Patent No.: **US 6,785,873 B1**
(45) Date of Patent: **Aug. 31, 2004**(54) **EMULATION SYSTEM WITH MULTIPLE ASYNCHRONOUS CLOCKS**(75) Inventor: **Ping-Sheng Tseng, Sunnyvale, CA (US)**(73) Assignee: **Axis Systems, Inc., Sunnyvale, CA (US)**

(*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 761 days.

(21) Appl. No.: **09/591,683**(22) Filed: **Jun. 9, 2000****Related U.S. Application Data**

(63) Continuation-in-part of application No. 09/546,554, filed on Apr. 10, 2000, which is a continuation-in-part of application No. 09/373,014, filed on Aug. 11, 1999, which is a continuation-in-part of application No. 09/144,222, filed on Aug. 31, 1999, now Pat. No. 6,321,366, which is a continuation-in-part of application No. 08/850,136, filed on May 2, 1997, now Pat. No. 6,009,256.

(51) Int. Cl.⁷ **G06F 17/50**(52) U.S. Cl. **716/4; 716/1**(58) Field of Search **716/4, 1, 5, 6**(56) **References Cited****U.S. PATENT DOCUMENTS**

3,836,889	A *	9/1974	Kotok et al.	710/264
4,144,448	A *	3/1979	Pisciotta et al.	714/814
4,688,947	A *	8/1987	Blaes et al.	368/120
5,126,950	A *	6/1992	Rees et al.	716/4
5,425,036	A *	6/1995	Liu et al.	714/735
5,596,742	A *	1/1997	Agarwal et al.	716/16
6,084,930	A *	7/2000	Dinteman	375/354
6,204,711	B1 *	3/2001	Scarlett et al.	327/291

OTHER PUBLICATIONS

O'Leary et al., "Synchronous Emulation of Asynchronous Circuits", Feb. 1997, IEEE Transactions on Computer-Aided Design of Integrated Circuit and System, vol. 16, iss. 2, pp. 205-209.*

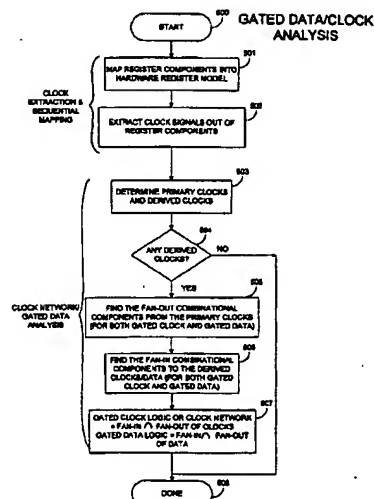
* cited by examiner

Primary Examiner—Matthew Smith*Assistant Examiner*—Sun James Lin(74) *Attorney, Agent, or Firm*—Burns, Doane, Swecker & Mathis LLP

(57)

ABSTRACT

An emulation system includes a clock generation logic for generating multiple asynchronous clocks, where each generated clock's relative phase relationship with respect to all other generated clocks is strictly controlled to speed up the emulation logic evaluation. Unlike statically designed emulator systems known in the prior art, the speed of the logic evaluation in the emulator need not be slowed down to the worst possible evaluation time since the clocking is generated internally in the emulator and carefully controlled. The emulation system does not concern itself with the absolute time duration of each clock, because only the phase relationship among the multiple asynchronous clocks is important. By retaining the phase relationship (and the initial values) among the multiple asynchronous clocks, the speed of the logic evaluation in the emulator can be increased. The RCC clock generation logic comprises a clock generation scheduler and a set of clock generation slices, where each clock generation slice generates a clock. The clock generation scheduler compares each clock's next toggle point from the current time, toggles the clock associated with the winning next toggle point, determines the new current time, updates the next toggle point information for all of the clock generation slices, and performs the comparison again in the next evaluation cycle. In the update phase, the winning slice updates its register with a new next toggle point, while the losing slices merely updates their respective registers by adjusting for the new current time.

20 Claims, 99 Drawing Sheets



US005384710A

United States Patent [19][11] **Patent Number:** **5,384,710**

Lam et al.

[45] **Date of Patent:** **Jan. 24, 1995**[54] **CIRCUIT LEVEL NETLIST GENERATION**[75] **Inventors:** Nim C. Lam, Sunnyvale; Amrit K. Lalchandani, Mountain View, both of Calif.[73] **Assignee:** National Semiconductor Corporation, Santa Clara, Calif.[21] **Appl. No.:** 173,808[22] **Filed:** Dec. 22, 1993**Related U.S. Application Data**

[63] Continuation of Ser. No. 493,057, Mar. 13, 1990, abandoned.

[51] **Int. Cl.⁶** G06F 15/60[52] **U.S. Cl.** 364/489; 364/488[58] **Field of Search** 364/488, 489, 490, 491[56] **References Cited****U.S. PATENT DOCUMENTS**

4,635,208	1/1987	Coleby et al.	364/491
4,831,543	5/1989	Mastellone	364/489
4,922,432	5/1990	Kobayashi et al.	364/490
4,967,367	10/1990	Piednoir	364/489
5,038,294	8/1991	Arakawa et al.	364/491
5,084,824	1/1992	Lam et al.	364/490

OTHER PUBLICATIONS

"Hierarchical Functional Verification for Cell-Based Design Styles" by Chen et al., IEEE Proceedings, vol. 134, Part G, No. 2, Apr. 1987, pp. 103-109.

"Programs for Verifying Circuit Connectivity of

MOS/LSI Mask Artwork" by Takashima et al., IEEE 19th Design Automation Conf., 1982, pp. 544-550.

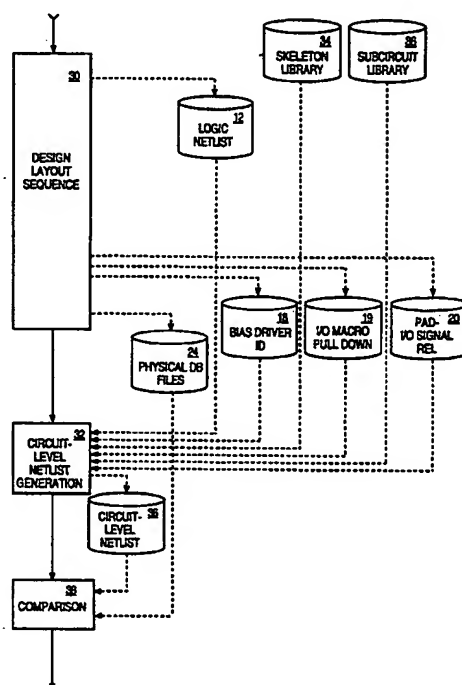
Primary Examiner—Vincent N. Trans
Attorney, Agent, or Firm—H. Donald Nelson; David H. Carroll; Stephen R. Robinson

[57] **ABSTRACT**

A design layout sequence for an application specific integrated circuit such as a gate array includes a schematic capture step, which results in a logic netlist file, and a placement and routing step which results in a number of various files defining, for example, bias drivers, I/O macros, and relationships between chip pads and I/O signals. The design layout sequence culminates in a physical data base file. The connectivity of this physical data base file is checked by first generating a circuit level netlist file for the entire option, and then comparing the circuit level netlist with the physical data base file. In generating the circuit level netlist file, information is obtained from the logic netlist file, as well as from some of the other files created in the design-layout sequence. In addition, basic information from which the circuit level netlist is constructed is obtained from a skeleton file library and a subcircuit library. The contents and methodology for deriving the skeleton file library and the subcircuit library are discussed.

11 Claims, 53 Drawing Sheets

Microfiche Appendix Included
 (483 Microfiche, 6 Pages)



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Search Results - Record(s) 1 through 11 of 11 returned.

☐ 1. Document ID: US 20050027491 A1

Using default format because multiple data bases are involved.

L6: Entry 1 of 11

File: PGPB

Feb 3, 2005

PGPUB-DOCUMENT-NUMBER: 20050027491

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20050027491 A1

TITLE: Symbolic analysis of electrical circuits for application in telecommunications

PUBLICATION-DATE: February 3, 2005

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Fertner, Antoni	Solna		SE	
Luppert, Edwin	Sodertalje		SE	

US-CL-CURRENT: 702/196

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KWIC	Draw De
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☐ 2. Document ID: US 6577992 B1

L6: Entry 2 of 11

File: USPT

Jun 10, 2003

US-PAT-NO: 6577992

DOCUMENT-IDENTIFIER: US 6577992 B1

TITLE: Transistor level circuit simulator using hierarchical data

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw De
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☐ 3. Document ID: US 6563150 B1

L6: Entry 3 of 11

File: USPT

May 13, 2003

US-PAT-NO: 6563150

DOCUMENT-IDENTIFIER: US 6563150 B1

TITLE: High frequency field effect transistor

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw. De
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☐ 4. Document ID: US 6134513 A

L6: Entry 4 of 11

File: USPT

Oct 17, 2000

US-PAT-NO: 6134513

DOCUMENT-IDENTIFIER: US 6134513 A

TITLE: Method and apparatus for simulating large, hierarchical microelectronic resistor circuits

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw. De
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☐ 5. Document ID: US 5861644 A

L6: Entry 5 of 11

File: USPT

Jan 19, 1999

US-PAT-NO: 5861644

DOCUMENT-IDENTIFIER: US 5861644 A

TITLE: High-frequency traveling wave field-effect transistor

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw. De
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☐ 6. Document ID: US 5627389 A

L6: Entry 6 of 11

File: USPT

May 6, 1997

US-PAT-NO: 5627389

DOCUMENT-IDENTIFIER: US 5627389 A

**** See image for Certificate of Correction ****

TITLE: High-frequency traveling wave field-effect transistor

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw. De
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☐ 7. Document ID: US 5502392 A

L6: Entry 7 of 11

File: USPT

Mar 26, 1996

US-PAT-NO: 5502392

DOCUMENT-IDENTIFIER: US 5502392 A

TITLE: Methods for the measurement of the frequency dependent complex propagation matrix, impedance matrix and admittance matrix of coupled transmission lines

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw. De
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☐ 8. Document ID: US 5467291 A

L6: Entry 8 of 11

File: USPT

Nov 14, 1995

US-PAT-NO: 5467291

DOCUMENT-IDENTIFIER: US 5467291 A

TITLE: Measurement-based system for modeling and simulation of active semiconductor devices over an extended operating frequency range

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw D
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☐ 9. Document ID: US 5394346 A

L6: Entry 9 of 11

File: USPT

Feb 28, 1995

US-PAT-NO: 5394346

DOCUMENT-IDENTIFIER: US 5394346 A

TITLE: Simulation of an electronic system including analog and digital circuitry using high level macro models

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw D
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☐ 10. Document ID: US 5313398 A

L6: Entry 10 of 11

File: USPT

May 17, 1994

US-PAT-NO: 5313398

DOCUMENT-IDENTIFIER: US 5313398 A

TITLE: Method and apparatus for simulating a microelectronic circuit

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw D
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☐ 11. Document ID: US 4677386 A

L6: Entry 11 of 11

File: USPT

Jun 30, 1987

US-PAT-NO: 4677386

DOCUMENT-IDENTIFIER: US 4677386 A

**** See image for Certificate of Correction ****

TITLE: Method of interpreting impedance distribution of an earth formation obtained by a moving array using end emitting current electrodes sequentially activated and a series of potential electrodes

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KWIC	Draw D
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11

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☐ 1. Document ID: US 20050049838 A1

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L13: Entry 1 of 24

File: PGPB

Mar 3, 2005

PGPUB-DOCUMENT-NUMBER: 20050049838

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20050049838 A1

TITLE: Multiphase physical transport modeling method and modeling system

PUBLICATION-DATE: March 3, 2005

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Danko, George	Reno	NV	US	

US-CL-CURRENT: 703/2

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KIMC	Draw Ds
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☐ 2. Document ID: US 20050027491 A1

L13: Entry 2 of 24

File: PGPB

Feb 3, 2005

PGPUB-DOCUMENT-NUMBER: 20050027491

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20050027491 A1

TITLE: Symbolic analysis of electrical circuits for application in telecommunications

PUBLICATION-DATE: February 3, 2005

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Fertner, Antoni	Solna		SE	
Luppert, Edwin	Sodertalje		SE	

US-CL-CURRENT: 702/196

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KIMC	Draw Ds
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☐ 3. Document ID: US 20040031001 A1

L13: Entry 3 of 24

File: PGPB

Feb 12, 2004

PGPUB-DOCUMENT-NUMBER: 20040031001

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20040031001 A1

TITLE: MOSFET modeling for IC design accurate for high frequencies

PUBLICATION-DATE: February 12, 2004

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Zhang, Xisheng	Sunnyvale	CA	US	
Liang, Hancheng	San Jose	CA	US	
Liu, Zhihong	Cupertino	CA	US	
Guo, Jianhe	Santa Clara	CA	US	

US-CL-CURRENT: 716/4; 703/14

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KMC	Draw D
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☐ 4. Document ID: US 20030200039 A1

L13: Entry 4 of 24

File: PGPB

Oct 23, 2003

PGPUB-DOCUMENT-NUMBER: 20030200039

PGPUB-FILING-TYPE: new

DOCUMENT-IDENTIFIER: US 20030200039 A1

TITLE: Method, apparatus, and article of manufacture for predicting electrical behavior of a multiport device having balanced device ports

PUBLICATION-DATE: October 23, 2003

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Adamian, Vahe?apos; A.	Lexington	MA	US	
Cole, J. Bradford	Westford	MA	US	

US-CL-CURRENT: 702/65

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KMC	Draw D
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☐ 5. Document ID: US 20020183990 A1

L13: Entry 5 of 24

File: PGPB

Dec 5, 2002

PGPUB-DOCUMENT-NUMBER: 20020183990
PGPUB-FILING-TYPE: new
DOCUMENT-IDENTIFIER: US 20020183990 A1

TITLE: Circuit simulation

PUBLICATION-DATE: December 5, 2002

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Wasynczuk, Oleg	West Lafayette	IN	US	
Jatskevich, Juri V.	Lafayette	IN	US	

US-CL-CURRENT: 703/2

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KMC	Draw De
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☐ 6. Document ID: US 20010029601 A1

L13: Entry 6 of 24

File: PGPB

Oct 11, 2001

PGPUB-DOCUMENT-NUMBER: 20010029601
PGPUB-FILING-TYPE: new
DOCUMENT-IDENTIFIER: US 20010029601 A1

TITLE: Semiconductor device analyzer, method for analyzing/manufacturing semiconductor device, and storage medium storing program for analyzing semiconductor device

PUBLICATION-DATE: October 11, 2001

INVENTOR-INFORMATION:

NAME	CITY	STATE	COUNTRY	RULE-47
Kimura, Tomohisa	Tokyo		JP	
Okumura, Makiko	Kanagawa		JP	

US-CL-CURRENT: 716/19; 716/4

Full	Title	Citation	Front	Review	Classification	Date	Reference	Sequences	Attachments	Claims	KMC	Draw De
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☐ 7. Document ID: US 6851097 B2

L13: Entry 7 of 24

File: USPT

Feb 1, 2005

US-PAT-NO: 6851097
DOCUMENT-IDENTIFIER: US 6851097 B2

TITLE: MOSFET modeling for IC design accurate for high frequencies

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KMC	Draw De
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☐ 8. Document ID: US 6785625 B1

L13: Entry 8 of 24

File: USPT

Aug 31, 2004

US-PAT-NO: 6785625

DOCUMENT-IDENTIFIER: US 6785625 B1

TITLE: Characterizing multi-port cascaded networks

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KMC	Draw. De
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☐ 9. Document ID: US 6757625 B2

L13: Entry 9 of 24

File: USPT

Jun 29, 2004

US-PAT-NO: 6757625

DOCUMENT-IDENTIFIER: US 6757625 B2

TITLE: Method, apparatus, and article of manufacture for predicting electrical behavior of a multiport device having balanced device ports

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KMC	Draw. De
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☐ 10. Document ID: US 6618837 B1

L13: Entry 10 of 24

File: USPT

Sep 9, 2003

US-PAT-NO: 6618837

DOCUMENT-IDENTIFIER: US 6618837 B1

**** See image for Certificate of Correction ****

TITLE: MOSFET modeling for IC design accurate for high frequencies

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KMC	Draw. De
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☐ 11. Document ID: US 6563150 B1

L13: Entry 11 of 24

File: USPT

May 13, 2003

US-PAT-NO: 6563150

DOCUMENT-IDENTIFIER: US 6563150 B1

TITLE: High frequency field effect transistor

Full	Title	Citation	Front	Review	Classification	Date	Reference			Claims	KMC	Draw. De
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☐ 12. Document ID: US 6202041 B1

L13: Entry 12 of 24

File: USPT

Mar 13, 2001

US-PAT-NO: 6202041

DOCUMENT-IDENTIFIER: US 6202041 B1

TITLE: Electrical power network modelling method

Full	Title	Citation	Front	Review	Classification	Date	Reference	Claims	KWIC	Draw. De
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☐ 13. Document ID: US 5946482 A

L13: Entry 13 of 24

File: USPT

Aug 31, 1999

US-PAT-NO: 5946482

DOCUMENT-IDENTIFIER: US 5946482 A

TITLE: Method and apparatus for using parameters to simulate an electronic circuit

Full	Title	Citation	Front	Review	Classification	Date	Reference	Claims	KWIC	Draw. De
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☐ 14. Document ID: US 5781764 A

L13: Entry 14 of 24

File: USPT

Jul 14, 1998

US-PAT-NO: 5781764

DOCUMENT-IDENTIFIER: US 5781764 A

**** See image for Certificate of Correction ****

TITLE: Method and apparatus for generation a system component model and for evaluation system parameters in relation to such model

Full	Title	Citation	Front	Review	Classification	Date	Reference	Claims	KWIC	Draw. De
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☐ 15. Document ID: US 5777475 A

L13: Entry 15 of 24

File: USPT

Jul 7, 1998

US-PAT-NO: 5777475

DOCUMENT-IDENTIFIER: US 5777475 A

TITLE: Automatic impedance adapter for a H.F. emitter or receiver in a nuclear spin tomography installation and process for operating the device

Full	Title	Citation	Front	Review	Classification	Date	Reference	Claims	KWIC	Draw. De
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